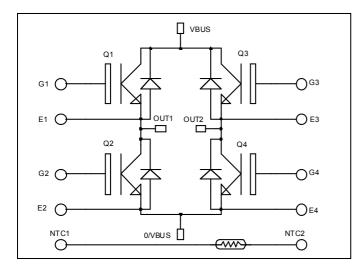
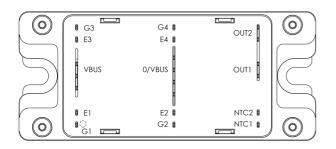


# APTGF75H120TG

# Full - Bridge NPT IGBT Power Module





## Absolute maximum ratings

| Symbol           | Parameter                             |                        | Max ratings  | Unit |
|------------------|---------------------------------------|------------------------|--------------|------|
| V <sub>CES</sub> | Collector - Emitter Breakdown Voltage |                        | 1200         | V    |
| I <sub>C</sub>   | Continuous Collector Current          | $T_c = 25^{\circ}C$    | 100          |      |
| 1 <sub>C</sub>   | Continuous Conector Current           | $T_c = 80^{\circ}C$    | 75           | А    |
| I <sub>CM</sub>  | Pulsed Collector Current              | $T_c = 25^{\circ}C$    | 150          |      |
| V <sub>GE</sub>  | Gate – Emitter Voltage                |                        | ±20          | V    |
| PD               | Maximum Power Dissipation             | $T_c = 25^{\circ}C$    | 500          | W    |
| RBSOA            | Reverse Bias Safe Operating Area      | $T_{j} = 150^{\circ}C$ | 150A @ 1200V |      |

## CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

www.microsemi.com

## $V_{CES} = 1200V$ $I_{C} = 75A$ (a) $Tc = 80^{\circ}C$

### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### Features

- Non Punch Through (NPT) Fast IGBT
  - Low voltage drop
    - Low tail current
  - Switching frequency up to 50 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
  - Symmetrical design
  - Lead frames for power connections
- Internal thermistor for temperature monitoring
- High level of integration

#### Benefits

- Outstanding performance at high frequency operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Easy paralleling due to positive T<sub>C</sub> of V<sub>CEsat</sub>
- Low profile
- RoHS compliant

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## All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

## **Electrical Characteristics**

| Symbol               | Characteristic                       | Test Conditions                            |                        | Min | Тур | Max  | Unit |
|----------------------|--------------------------------------|--|------------------------|-----|-----|------|------|
| т                    | Zero Gate Voltage Collector Current  | $V_{GE} = 0V$                              | $T_j = 25^{\circ}C$    |     |     | 250  | ۸    |
| I <sub>CES</sub>     | Zero Gate Voltage Collector Current  | $V_{CE} = 1200 V$                          | $T_j = 125^{\circ}C$   |     |     | 500  | μA   |
| V                    | Collector Emitter acturation Voltage | $V_{GE} = 15V$                             | $T_j = 25^{\circ}C$    |     | 3.2 | 3.7  | V    |
| V <sub>CE(sat)</sub> | Collector Emitter saturation Voltage | $I_C = 75A$                                | $T_{j} = 125^{\circ}C$ |     | 3.9 |      | v    |
| V <sub>GE(th)</sub>  | Gate Threshold Voltage               | $V_{GE} = V_{CE}$ , $I_C = 2.5 \text{ mA}$ |                        | 4.5 |     | 6.5  | V    |
| I <sub>GES</sub>     | Gate – Emitter Leakage Current       | $V_{GE} = \pm 20V, V_{CE} = 0V$            |                        |     |     | ±500 | nA   |

## **Dynamic Characteristics**

| Symbol              | Characteristic               | Test Conditions   | Min | Тур | Max | Unit |
|---------------------|------------------------------|---|-----|-----|-----|------|
| Cies                | Input Capacitance            | $V_{GE} = 0V$   |     | 5.1 |     |      |
| Coes                | Output Capacitance           | $V_{CE} = 25V$  |     | 0.7 |     | nF   |
| C <sub>res</sub>    | Reverse Transfer Capacitance | f=1MHz  |     | 0.4 |     |      |
| Q <sub>G</sub>      | Gate charge                  | $V_{GE}=\pm 15V, I_C=75A$<br>$V_{CE}=600V$  |     | 0.8 |     | μC   |
| T <sub>d(on)</sub>  | Turn-on Delay Time           | Inductive Switching (25°C)  |     | 120 |     |      |
| Tr                  | Rise Time                    | $V_{GE} = 15V$  |     | 50  |     |      |
| T <sub>d(off)</sub> | Turn-off Delay Time          | $V_{Bus} = 600V$<br>$I_C = 75A$   |     | 310 |     | ns   |
| T <sub>f</sub>      | Fall Time                    | $R_{\rm G} = 7.5\Omega$   |     | 20  |     |      |
| T <sub>d(on)</sub>  | Turn-on Delay Time           | Inductive Switching (125°C  | C)  | 130 |     |      |
| Tr                  | Rise Time                    | $V_{GE} = 15V$  |     | 60  |     |      |
| T <sub>d(off)</sub> | Turn-off Delay Time          | $V_{Bus} = 600V$ $I_C = 75A$  |     | 360 |     | ns   |
| T <sub>f</sub>      | Fall Time                    | $R_{G} = 7.5\Omega$   |     | 30  |     |      |
| Eon                 | Turn-on Switching Energy     | $\begin{array}{ c c c } V_{GE} = \pm 15V \\ V_{Bus} = 600V \end{array}  T_j = 125^{\circ}C \end{array}$ |     | 9   |     | mJ   |
| E <sub>off</sub>    | Turn-off Switching Energy    | $\begin{bmatrix} I_{C} = 75A \\ R_{G} = 7.5\Omega \end{bmatrix} T_{j} = 125^{\circ}C$                   |     | 4   |     | 1113 |
| I <sub>sc</sub>     | Short Circuit data           | $V_{GE} \le 15V$ ; $V_{Bus} = 900V$<br>$t_p \le 10\mu s$ ; $T_i = 125^{\circ}C$                         |     | 450 |     | А    |

## **Reverse diode ratings and characteristics**

| Symbol           | Characteristic                          | Test Conditions                                |                        | Min  | Тур | Max | Unit  |
|------------------|---|--|------------------------|------|-----|-----|-------|
| V <sub>RRM</sub> | Maximum Peak Repetitive Reverse Voltage |  |                        | 1200 |     |     | V     |
| I <sub>RM</sub>  | Maximum Reverse Leakage Current         | V <sub>R</sub> =1200V                          | $T_j = 25^{\circ}C$    |      |     | 250 | μA    |
| -KW              |   | · K ·····                                      | $T_{j} = 125^{\circ}C$ |      |     | 500 | P** - |
| $I_{\rm F}$      | DC Forward Current                      |  | $Tc = 80^{\circ}C$     |      | 50  |     | А     |
| V                | D's he Francisch Welteren               | $I_F = 50A$                                    | $T_j = 25^{\circ}C$    |      | 2.1 |     | v     |
| $V_{\rm F}$      | Diode Forward Voltage                   |  | $T_{j} = 125^{\circ}C$ |      | 1.9 |     | v     |
| +                | D                                       |  | $T_j = 25^{\circ}C$    |      | 95  |     |       |
| t <sub>rr</sub>  | Reverse Recovery Time                   |  | $T_j = 125^{\circ}C$   |      | 190 |     | ns    |
| 0                | Powerse Possesser Charge                | $I_F = 50A$ $V_R = 600V$ $di/dt = 1500A/\mu s$ | $T_j = 25^{\circ}C$    |      | 4.2 |     | μC    |
| Q <sub>rr</sub>  | Reverse Recovery Charge                 |  | $T_{j} = 125^{\circ}C$ |      | 9   |     | μ     |
| Б                |   |  | $T_j = 25^{\circ}C$    |      | 1.5 |     | mI    |
| Er               | Reverse Recovery Energy                 |  | $T_j = 125^{\circ}C$   |      | 3   |     | mJ    |



# APTGF75H120TG

## Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

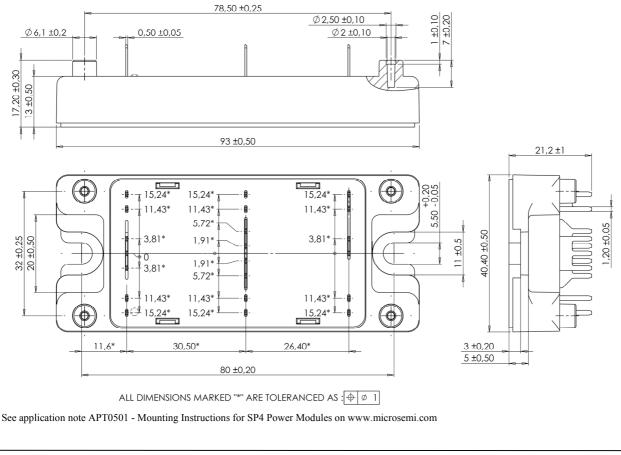
| Symbol                 | Characteristic              |                       | Min | Тур  | Max | Unit |
|------------------------|-----------------------------|-----------------------|-----|------|-----|------|
| R <sub>25</sub>        | Resistance @ 25°C           |                       |     | 50   |     | kΩ   |
| $\Delta R_{25}/R_{25}$ |                             |                       |     | 5    |     | %    |
| B <sub>25/85</sub>     | $T_{25} = 298.15 \text{ K}$ |                       |     | 3952 |     | K    |
| $\Delta B/B$           |                             | T <sub>C</sub> =100°C |     | 4    |     | %    |
|                        | B                           |                       |     |      |     |      |

 $R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$  T: Thermistor temperature R<sub>T</sub>: Thermistor value at T

## Thermal and package characteristics

| Symbol                    | Characteristic  |             |       | Min  | Тур | Max  | Unit |
|---------------------------|---|-------------|-------|------|-----|------|------|
| R <sub>thJC</sub>         | Junction to Case Thermal Resistance                           |             | IGBT  |      |     | 0.25 | °C/W |
| <b>R</b> <sub>th</sub> JC |   |             | Diode |      |     | 0.6  | C/ W |
| V <sub>ISOL</sub>         | RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz |             |       | 4000 |     |      | V    |
| TJ                        | Operating junction temperature range -40 150                  |             |       |      |     |      |      |
| T <sub>STG</sub>          | Storage Temperature Range                                     |             | -40   |      | 125 | °C   |      |
| T <sub>C</sub>            | Operating Case Temperature                                    |             |       | -40  |     | 100  |      |
| Torque                    | Mounting torque   | To heatsink | M5    | 2.5  |     | 4.7  | N.m  |
| Wt                        | Package Weight  |             |       |      |     | 160  | g    |

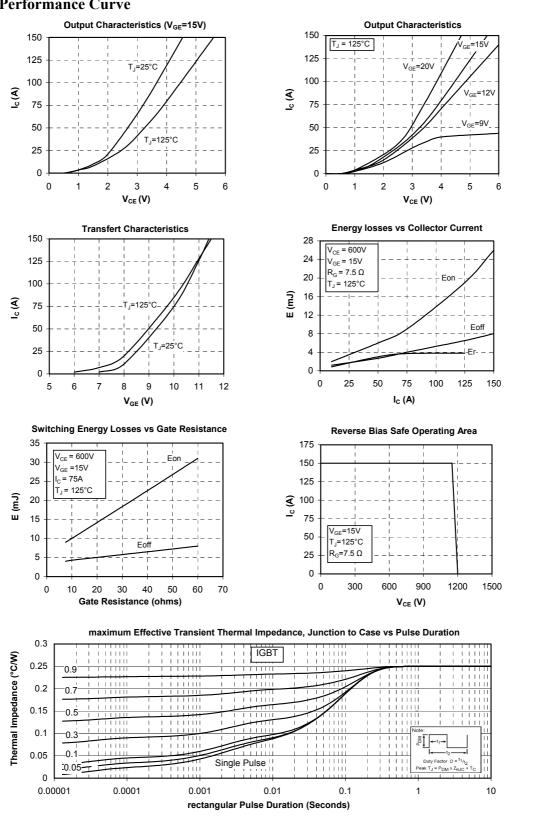
## SP4 Package outline (dimensions in mm)





### **Typical Performance Curve**



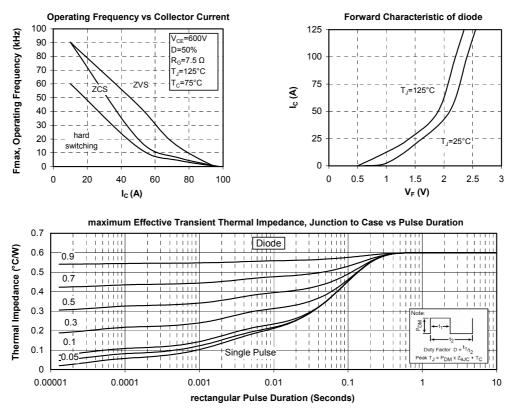


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